

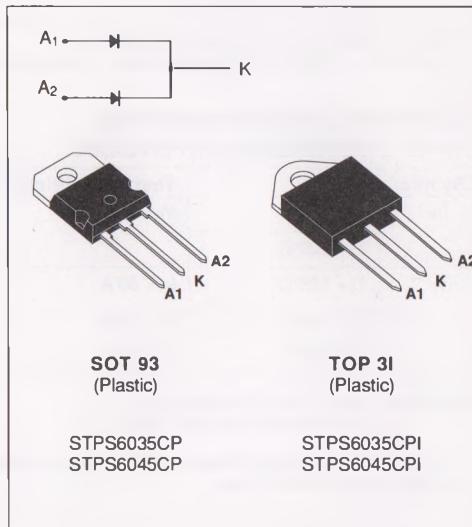
## POWER SCHOTTKY RECTIFIER

- VERY SMALL CONDUCTION LOSSES
- NEGLIGIBLE SWITCHING LOSSES
- EXTREMELY FAST SWITCHING
- LOW FORWARD VOLTAGE DROP
- HIGH AVALANCHE CAPABILITY
- LOW THERMAL RESISTANCE
- INSULATED PACKAGE :
  - Insulating voltage = 2500V<sub>RMS</sub>
  - Capacitance = 12pF

### DESCRIPTION

Dual center tap schottky rectifier suited for switch-mode power supply and high frequency DC to DC converters.

Packaged in SOT 93 and TOP 3I, this device is intended for use in low voltage, high frequency inverters, free wheeling and polarity protection applications.



### ABSOLUTE RATINGS (limiting values)

Symbol	Parameter			Value	Unit	
I <sub>F(RMS)</sub>	RMS Forward Current			60	A	
I <sub>F(AV)</sub>	Average Forward Current $\delta = 0.5$	SOT 93	T <sub>c</sub> = 125°C	Per diode	30	A
		TOP 3I	T <sub>c</sub> = 105°C	Per device	60	
I <sub>FSM</sub>	Surge Non Repetitive Forward Current		T <sub>p</sub> = 10 ms Sinusoidal	Per diode	400	A
I <sub>RRM</sub>	Peak Repetitive Reverse Current		T <sub>p</sub> = 2 µs F = 1KHz	Per diode	1	A
T <sub>stg</sub> T <sub>j</sub>	Storage and Junction Temperature Range			-65 to + 150	°C	
dV/dt	Critical Rate of Rise of Reverse Voltage			-65 to + 150		
				1000	V/µs	

Symbol	Parameter	STPS		Unit
		6035CP 6035CPI	6045CP 6045CPI	
V <sub>RRM</sub>	Repetitive Peak Reverse Voltage	35	45	V

**THERMAL RESISTANCE**

Symbol	Parameter			Value	Unit
$R_{TH(j-c)}$	Junction-case	SOT 93	Per diode total	0.95 0.55	°C/W
		TOP 31	Per diode total	1.8 1.1	
$R_{TH(c)}$	Coupling	SOT 93		0.15	°C/W
		TOP 31		0.4	

When the diodes 1 and 2 are used simultaneously :

$$\Delta T_J(\text{diode 1}) = P(\text{diode 1}) \times R_{TH}(\text{Per diode}) + P(\text{diode 2}) \times R_{TH(c)}$$

**ELECTRICAL CHARACTERISTICS****STATIC CHARACTERISTICS PER DIODE**

Symbol	Tests Conditions		Min.	Typ.	Max.	Unit
$I_F$ *	$T_j = 25^\circ\text{C}$	$V_R = V_{RRM}$			500	$\mu\text{A}$
	$T_j = 125^\circ\text{C}$				80	$\text{mA}$
$V_F$ **	$T_j = 125^\circ\text{C}$	$I_F = 60 \text{ A}$			0.78	V
	$T_j = 125^\circ\text{C}$	$I_F = 30 \text{ A}$			0.63	
	$T_j = 25^\circ\text{C}$	$I_F = 60 \text{ A}$			0.84	

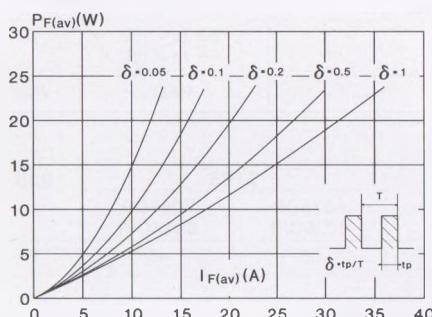
**Pulse test :** \*  $t_p = 5 \text{ ms}$ , duty cycle < 2 %

\*\*  $t_p = 380 \mu\text{s}$ , duty cycle < 2%

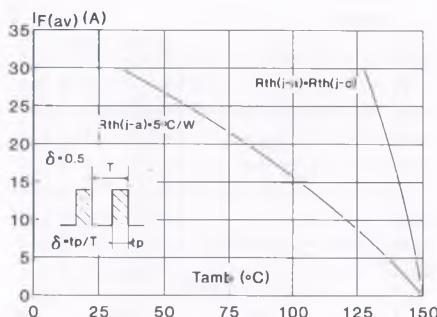
To evaluate the conduction losses use the following equation :

$$P = 0.48 \times I_{F(AV)} + 0.005 I_F^2(\text{RMS})$$

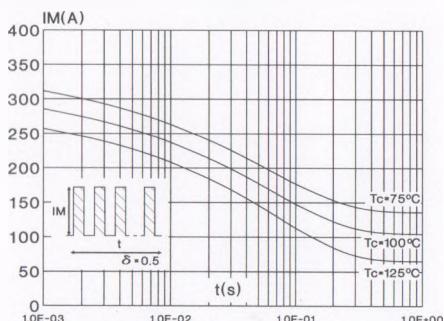
**Fig. 1 : Average forward power dissipation versus average forward current. (Per diode)**



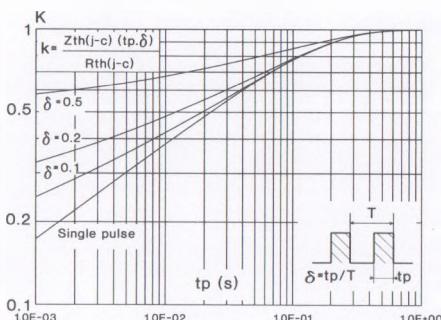
**Fig. 2 : Average current versus ambient temperature.**  
(duty cycle : 0.5) (Per diode) (SOT 93)



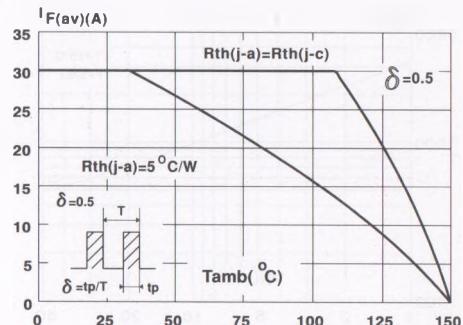
**Fig. 4 : Non repetitive surge peak forward current versus overload duration.**  
(Maximum values) (Per diode) (SOT 93)



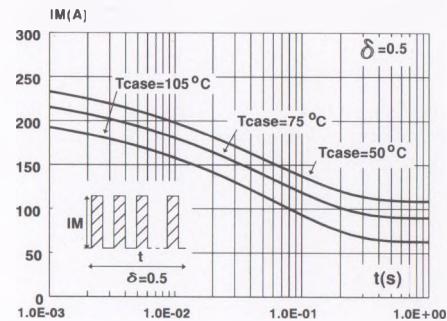
**Fig. 6 : Relative variation of thermal transient impedance junction to case versus pulse duration.**



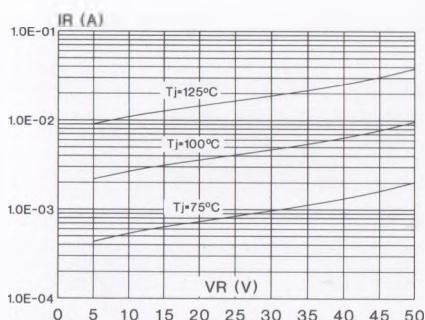
**Fig. 3 : Average current versus ambient temperature.**  
(duty cycle : 0.5) (Per diode) (TOP 3I)



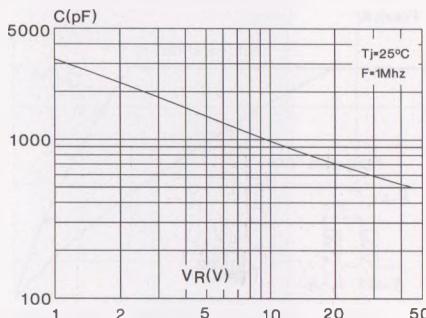
**Fig. 5 : Non repetitive surge peak forward current versus overload duration.**  
(Maximum values) (Per diode) (TOP 3I)



**Fig. 7 : Reverse leakage current versus reverse voltage applied.** (Typical values) (Per diode)



**Fig. 8** : Junction capacitance versus reverse voltage applied. (Typical values) (Per diode)



**Fig. 9** : Forward voltage drop versus forward current. (Maximum values)

